

# Cascadable Silicon Bipolar MMIC Amplifier

## Technical Data

#### **MSA-1105**

#### **Features**

- High Dynamic Range Cascadable 50  $\,\Omega$  or 75  $\,\Omega$  Gain Block
- 3 dB Bandwidth: 50 MHzto 1.3 GHz
- 17.5 dBm Typical  $P_{1\ dB}$  at 0.5 GHz
- 3.6 dB Typical Noise Figure at 0.5 GHz
- Surface Mount Plastic Package
- Tape-and-Reel Packaging Option Available<sup>[1]</sup>

#### Note:

 Refer to PACKAGING section "Tapeand-Reel Packaging for Semiconductor Devices."

#### **Description**

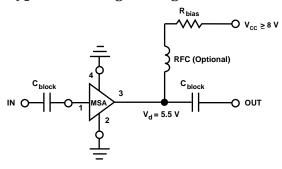
The MSA-1105 is a high performance silicon bipolar Monolithic Microwave Integrated Circuit (MMIC) housed in a low cost, surface mount plastic package. This MMIC is designed for high dynamic range in either 50 or 75  $\,\Omega$  systems by combining low noise figure with high IP3. Typical applications include narrow and broadband linear amplifiers in commercial and industrial systems.

The MSA-series is fabricated using HP's  $10\,\mathrm{GHz}\,\mathrm{f_{T}},25\,\mathrm{GHz}\,\mathrm{f_{MAX}}$  silicon bipolar MMIC process which uses nitride self-alignment, ion implantation, and gold metallization to achieve excellent performance, uniformity and reliability. The use of an external bias resistor for temperature and current stability also allows bias flexibility.

#### 05 Plastic Package



#### **Typical Biasing Configuration**



5965-9557E 6-458

**MSA-1105** Absolute Maximum Ratings

Parameter	Absolute Maximum <sup>[1]</sup>
Device Current	80 mA
Power Dissipation <sup>[2,3]</sup>	550 mW
RF Input Power	+13dBm
Junction Temperature	150℃
Storage Temperature	–65 to 150°C

Thermal Resistance $^{[2,4]}$ :	
$\theta_{\rm jc} = 125$ °C/W	

#### **Notes:**

- $1. \ \,$  Permanent damage may occur if any of these limits are exceeded.
- 2.  $T_{CASE} = 25$ °C.
- 3. Derate at 8 mW/°C for  $T_C > 124$ °C.
- 4. See MEASUREMENTS section "Thermal Resistance" for more information.

# Electrical Specifications<sup>[1]</sup>, $T_A = 25$ °C

Symbol	Parameters and Test Conditions:	Units	Min.	Тур.	Max.	
GP	Power Gain ( $ S_{21} ^2$ )	dB		12.7		
		f = 0.5  GHz	dB	10.0	12.0	
		f = 1.0  GHz	dB		10.5	
$\Delta G_P$	Gain Flatness	f = 0.1  to  1.0  GHz	dB		± 1.0	
f <sub>3 dB</sub>	3 dB Bandwidth <sup>[2]</sup>		GHz		1.3	
VSWR	Input VSWR	f = 0.1  to  1.0  GHz			1.5:1	
	Output VSWR	f = 0.1  to  1.0  GHz			1.7:1	
NF	$50\Omega$ Noise Figure	f = 0.5  GHz	dB		3.6	
P <sub>1 dB</sub>	Output Power at 1 dB Gain Compression	f = 0.5  GHz	dBm		17.5	
IP3	Third Order Intercept Point	f = 0.5  GHz	dBm		30.0	
$t_{\mathrm{D}}$	Group Delay	f = 0.5  GHz	psec		200	
Vd	Device Voltage		V	4.4	5.5	6.6
dV/dT	Device Voltage Temperature Coefficient		mV/°C		-8.0	

#### Notes:

- 1. The recommended operating current range for this device is 40 to 70 mA. Typical performance as a function of current is on the following page.
- 2. Referenced from 50 MHz gain ( $G_P$ ).

**Part Number Ordering Information** 

Part Number	No. of Devices	Container			
MSA-1105-TR1	500	7" Reel			
MSA-1105-STR	10	Antistatic Bag			

For more information, see "Tape and Reel Packaging for Semiconductor Devices".

MSA-1105 Typical Scattering Parameters (Z  $_{O}$  = 50  $\Omega,$   $T_{A}$  = 25  $^{\circ}C,$   $I_{d}$  = 60 mA)

Freq.	$\mathbf{S}_1$	S <sub>11</sub>		$\mathbf{S}_{21}$		S <sub>12</sub>			$\mathbf{S}_{22}$		
GHz	Mag	Ang	dB	Mag	Ang	dB	Mag	Ang	Mag	Ang	k
.0005	.80	-17	19.0	8.94	171	-26.0	.050	51	.81	-16	0.53
.005	.26	<b>-</b> 62	13.9	4.98	163	-16.8	.144	15	.26	<b>-</b> 64	0.93
.025	.07	-48	12.8	4.36	174	-16.4	.151	4	.08	<b>-</b> 52	1.08
.050	.06	-38	12.7	4.33	174	-16.3	.153	2	.06	<del>-4</del> 8	1.08
.100	.05	<b>-4</b> 1	12.7	4.31	170	-16.4	.152	3	.06	<b>-</b> 52	1.09
.200	.06	-58	12.6	4.26	162	-16.2	.155	5	.08	<b>-</b> 73	1.08
.300	.07	<b>-74</b>	12.4	4.19	154	-16.1	.157	7	.10	<b>-</b> 91	1.07
.400	.09	<b>-</b> 91	12.2	4.10	146	-15.8	.163	8	.12	-105	1.06
.500	.10	-105	12.0	4.00	138	-15.6	.166	8	.14	-116	1.05
.600	.11	<b>-</b> 116	11.8	3.88	131	-15.4	.171	10	.17	-126	1.04
.700	.13	-128	11.5	3.76	123	-15.0	.178	11	.18	-135	1.03
.800	.15	-136	11.2	3.63	116	-14.7	.184	11	.21	<b>-</b> 144	1.01
.900	.16	<b>-</b> 145	10.9	3.49	109	-15.5	.188	11	.22	<b>-</b> 151	1.01
1.000	.18	<b>-</b> 152	10.5	3.37	102	-14.1	.197	11	.24	-159	1.00
1.500	.28	174	8.8	2.75	72	-13.2	.219	7	.31	170	1.00
2.000	.38	150	7.1	2.28	48	-12.1	.248	0	.34	151	0.99
2.500	.46	133	5.6	1.90	28	-11.9	.254	<del>-4</del>	.38	134	1.02
3.000	.53	118	4.2	1.62	11	-11.6	.262	<del>-</del> 8	.40	122	1.04

A model for this device is available in the DEVICE MODELS section.

## Typical Performance, $T_A = 25$ °C, $Z_O = 50$ $\Omega$

(unless otherwise noted)

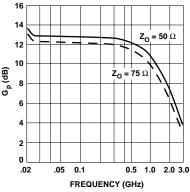


Figure 1. Typical Power Gain vs. Frequency,  $I_{d}=60\ mA.$ 

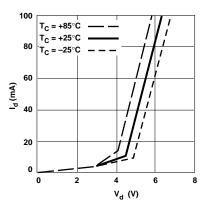


Figure 2. Device Current vs. Voltage.

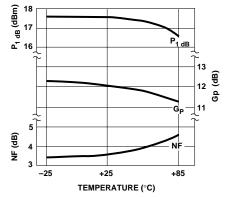


Figure 3. Output Power at 1 dB Gain Compression, Noise Figure and Power Gain vs. Case Temperature,  $f=0.5~GHz,\,I_d=60~mA.$ 

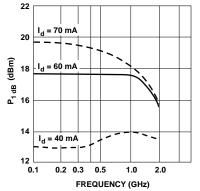
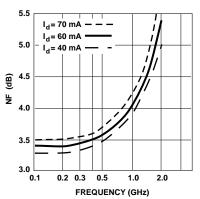
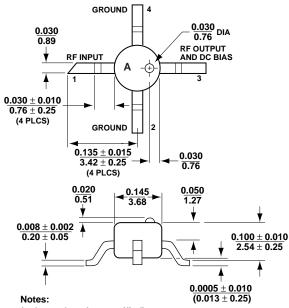


Figure 4. Output Power at 1 dB Gain Compression vs. Frequency.



**Figure 5. Noise Figure vs. Frequency.** 6-460

### **05 Plastic Package Dimensions**



(unless otherwise specified)

1. Dimensions are in mm

- 2. Tolerances

in .xxx =  $\pm$  0.005 mm .xx =  $\pm$  0.13